PROBE STATION HAVING MULTIPLE ENCLOSURES

ABSTRACT OF THE DISCLOSURE

A probe station for probing a test device has

a chuck element for supporting the test device. An
electrically conductive outer shield enclosure at least
partially encloses such chuck element to provide EMI
shielding therefor. An electrically conductive inner
shield enclosure is interposed between and insulated from
the outer shield enclosure and the chuck element, and at
least partially encloses the chuck element.

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